

Search Notes

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10/519,227

Examiner

John P. Sheehan

Applicant(s)/Patent under
Reexamination

CHOI ET AL.

Art Unit

1793

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG Pub	Search	6/15/2008	JPS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/15/2008	JPS
PALM Inventor Name Search	6/15/2008	JPS